

### Features

- Low  $R_{DS(on)}$
- Ultra-low  $Q_G$  For High Efficiency
- Logic Level
- Light Weight
- Compact Hermetic Package
- Source Sense Pin
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
  - SEE immunity for LET of 83.2 MeV/(mg/cm<sup>2</sup>) in Si with  $V_{DS}$  up to 83% of rated Breakdown
- Low Dose Rate at 100 mRad/sec
  - Maintains Pre-Rad specification
- Neutron
  - Maintains Pre-Rad specification for up to  $4 \times 10^{13}$  Neutrons/cm<sup>2</sup>



## EPC7008CC

**Rad-Hard eGaN® HEMT 300 V, 6 A, 370 mΩ Surface Mount (FSMD-C)**

### Description

EPC Space FSMD-C series of eGaN® power switching HEMTs have been specifically designed for critical applications in the high reliability or commercial satellite space environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low  $R_{DS(on)}$  values. The lateral structure of the die provides for very low gate charge ( $Q_G$ ) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

### Application

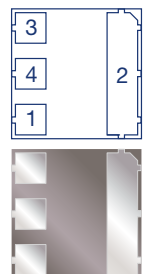
- Commercial Satellite EPS & Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers

### Thermal Characteristics

| Symbol          | Parameter-Conditions                            | Value | Units |
|-----------------|---|-------|-------|
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient (Note 3) | 42.75 | °C/W  |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case             | 9.22  |       |

### I/O Pin Assignment (Bottom View)

| Pin | Symbol | Description  |
|-----|--------|--------------|
| 1   | G      | Gate         |
| 2   | D      | Drain        |
| 3   | SS     | Source Sense |
| 4   | S      | Source       |



### Absolute Maximum Rating ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

| Symbol         | Parameter-Conditions   | Value            | Units |
|----------------|--|------------------|-------|
| $V_{DS}$       | Drain to Source Voltage (Note 1)   | 300              | V     |
| $I_D$          | Continuous Drain Current $I_D$ @ $V_{GS} = 5\text{ V}$ , $T_C = 25^\circ\text{C}$ , $R_{\theta JA} < 62^\circ\text{C/W}$ | 6                | A     |
| $I_{DM}$       | Single-Pulse Drain Current $t_{pulse} \leq 80\ \mu\text{s}$  | 18               |       |
| $V_{GS}$       | Gate to Source Voltage (Note 2)  | +6 / -4          | V     |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range   | -55 to +150      | °C    |
| $T_{sol}$      | Package Mounting Surface Temperature   | 260              | °C    |
| <b>ESD</b>     | ESD Class  | 1A( $\Delta A$ ) |       |
| <b>Weight</b>  | Device Weight  | 0.113            | g     |

**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted. Typical (TYP) values are for reference only.)

| Parameter  | Symbol                       | Test Conditions                                  | MIN | TYP  | MAX | Units                      |
|--|------------------------------|--|-----|------|-----|----------------------------|
| Maximum Drain to Source Voltage                          | $V_{DSMAX}$                  | $V_G = 0\text{ V}$                               | 300 |      |     | V                          |
| Drain to Source Leakage                                  | $I_{DSS}$                    | $V_{DS} = 300\text{ V}$<br>$V_{GS} = 0\text{ V}$ |     | 10   | 100 | $\mu\text{A}$              |
| Gate to Source Forward Leakage                           | $I_{GSSF}$                   | $V_{GS} = 6\text{ V}$                            |     | 250  | 600 |                            |
| Gate to Source Reverse Leakage                           | $I_{GSSR}$                   | $V_{GS} = -4\text{ V}$                           |     | 20   | 100 |                            |
| Gate to Source Threshold Voltage                         | $V_{GS(th)}$                 | $V_{DS} = V_{GS}, I_D = 0.6\text{ mA}$           | 0.8 | 1.2  | 2.5 | V                          |
| Gate to Source Threshold Voltage Temperature Coefficient | $\Delta V_{GS(th)}/\Delta T$ | $V_{DS} = V_{GS}, I_D = 0.6\text{ mA}$           |     | 0.5  |     | $\text{mV}/^\circ\text{C}$ |
| Drain to Source Resistance (Note 4)                      | $R_{DS(on)}$                 | $I_D = 6\text{ A}, V_{GS} = 5\text{ V}$          |     | 210  | 370 | $\text{m}\Omega$           |
| Source to Drain Forward Voltage                          | $V_{SD}$                     | $I_S = 0.5\text{ A}, V_G = 0\text{ V}$           |     | 1.75 | 3   | V                          |

**Dynamic Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted. Typical (TYP) values are for reference only.)

| Parameter                                | Symbol    | Test Conditions  | MIN | TYP | MAX | Units       |
|--|-----------|--|-----|-----|-----|-------------|
| Input Capacitance                        | $C_{ISS}$ | $f = 1\text{ MHz}, V_{DS} = 150\text{ V}, V_{GS} = 0\text{ V}$ |     | 380 | 400 | $\text{pF}$ |
| Output Capacitance                       | $C_{OSS}$ |  |     | 48  | 80  |             |
| Reverse transfer Capacitance             | $C_{RSS}$ |  |     | 2   | 4   |             |
| Gate Resistance (Note 5)                 | $R_G$     | $f = 1\text{ MHz}, V_{DS} = V_{GS} = 0\text{ V}$               |     | 0.4 |     | $\Omega$    |
| Total Gate Charge (Note 6)               | $Q_G$     | $I_D = 6\text{ A}, V_{GS} = 5\text{ V}, V_{DS} = 150\text{ V}$ |     | 1.6 | 3   | $\text{nC}$ |
| Gate to Drain Charge (Note 6)            | $Q_{GD}$  | $I_D = 6\text{ A}, V_{GS} = 5\text{ V}, V_{DS} = 150\text{ V}$ |     | 1.1 | 1.7 |             |
| Gate to Source Charge (Note 6)           | $Q_{GS}$  | $I_D = 6\text{ A}, V_{GS} = 5\text{ V}, V_{DS} = 150\text{ V}$ |     | 0.9 | 2   |             |
| Output Charge (Note 5)                   | $Q_{OSS}$ | $V_{GS} = 0\text{ V}, V_{DS} = 150\text{ V}$                   |     | 40  |     |             |
| Source to Drain Recovery Charge (Note 5) | $Q_{RR}$  | $I_D = 6\text{ A}, V_{DS} = 150\text{ V}$                      |     | <1  |     |             |

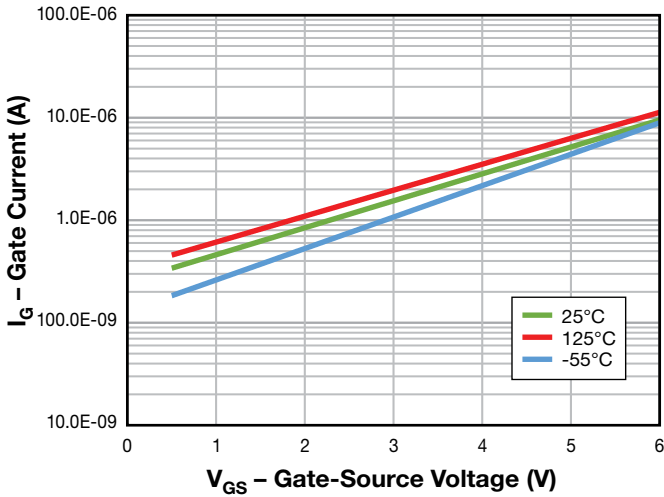


Figure 1: Typical Output Characteristics at 25°C

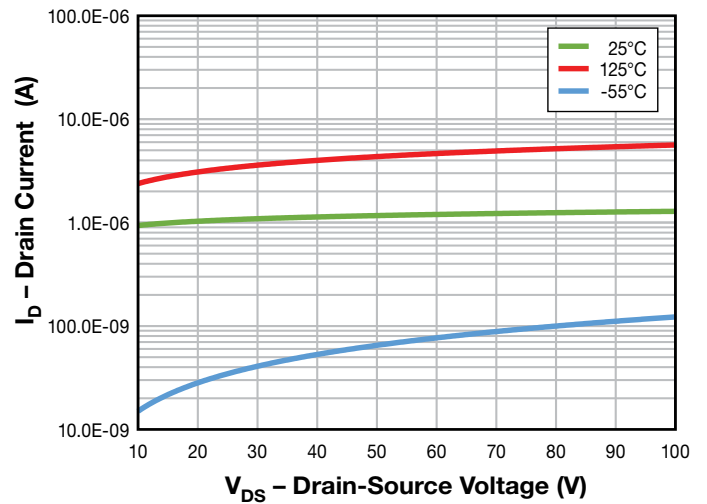


Figure 2: Typical Output Characteristics at 125°C

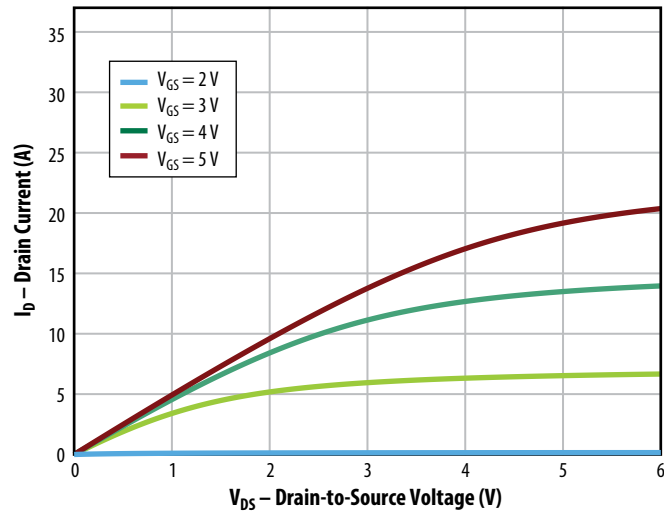


Figure 3: Typical Output Characteristics at 25°C

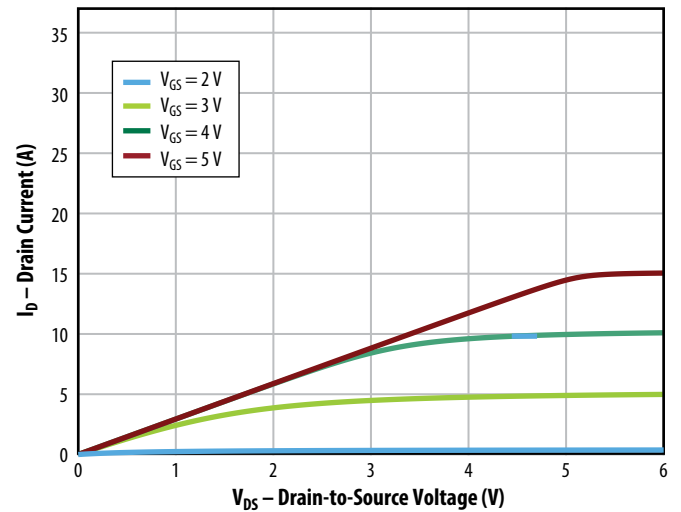


Figure 4: Typical Output Characteristics at 125°C

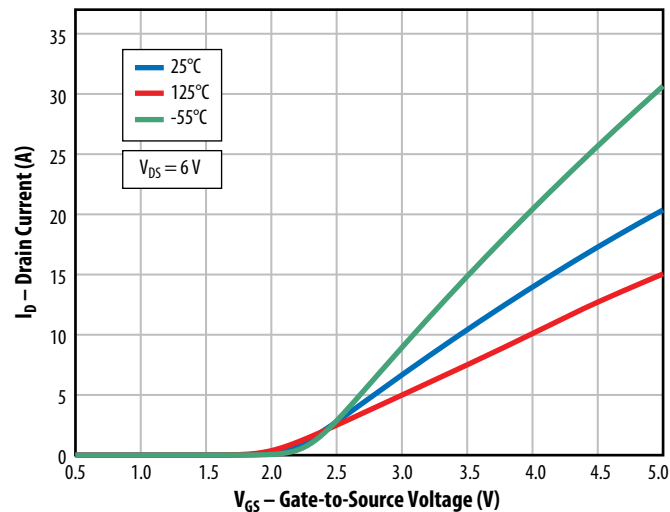


Figure 5: Typical Transfer Characteristics

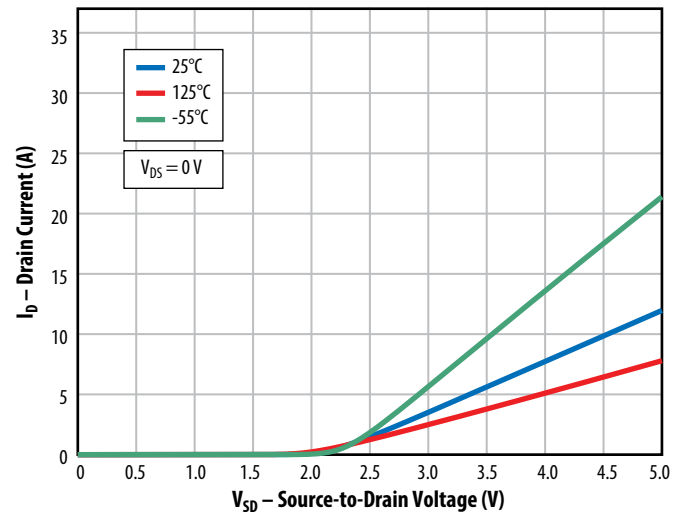


Figure 6: Reverse Drain-Source Characteristics

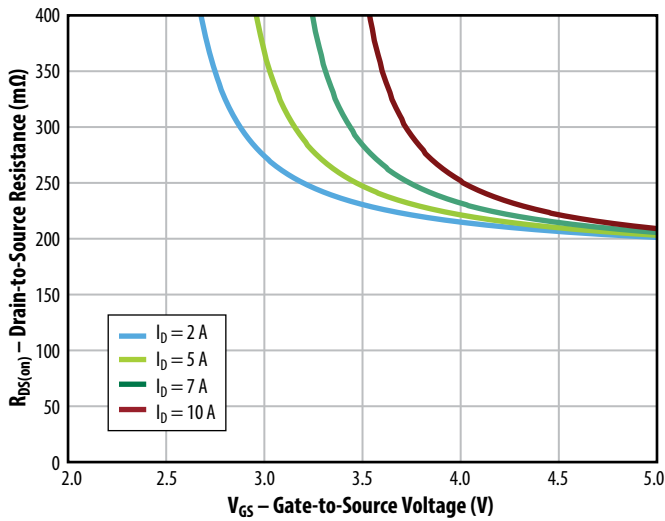


Figure 7:  $R_{DS(on)}$  vs.  $V_{GS}$  for Various Drain Currents

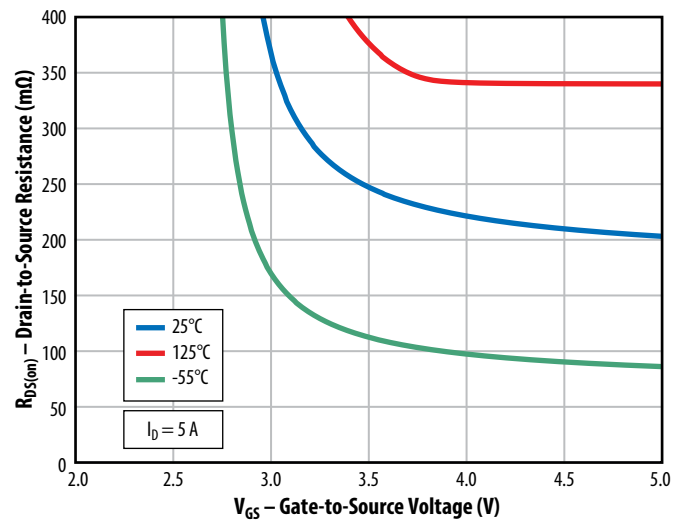


Figure 8:  $R_{DS(on)}$  vs.  $V_{GS}$  for Various Temperatures

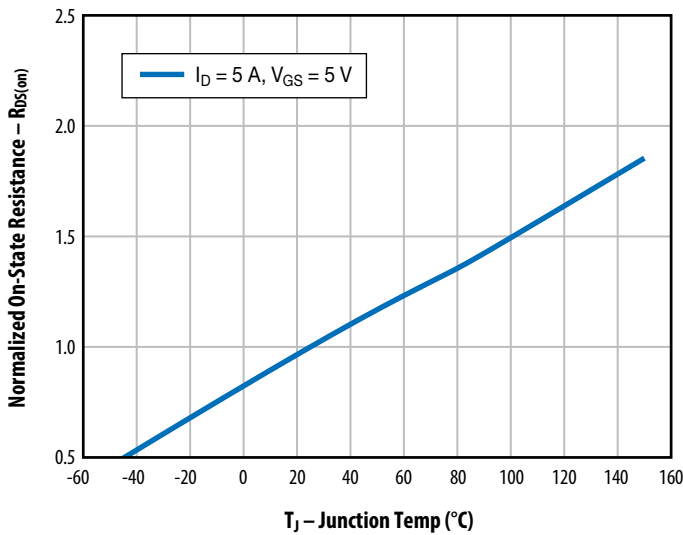


Figure 9: Normalized On-State Resistance vs. Temp.

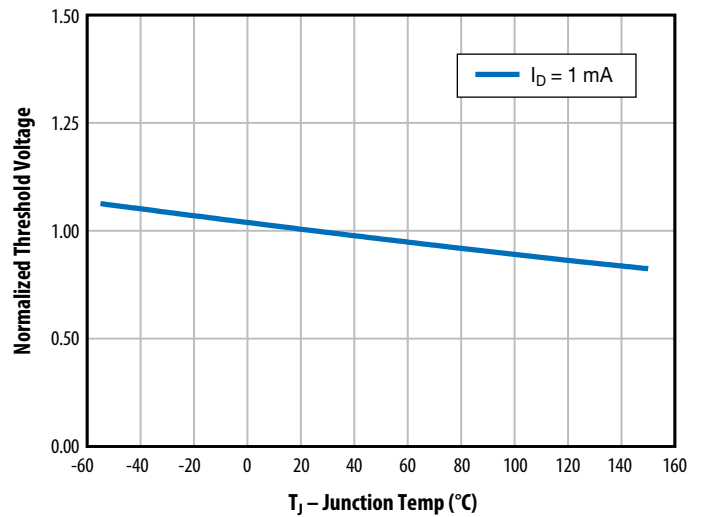


Figure 10: Normalized Gate Threshold Voltage vs. Temp.

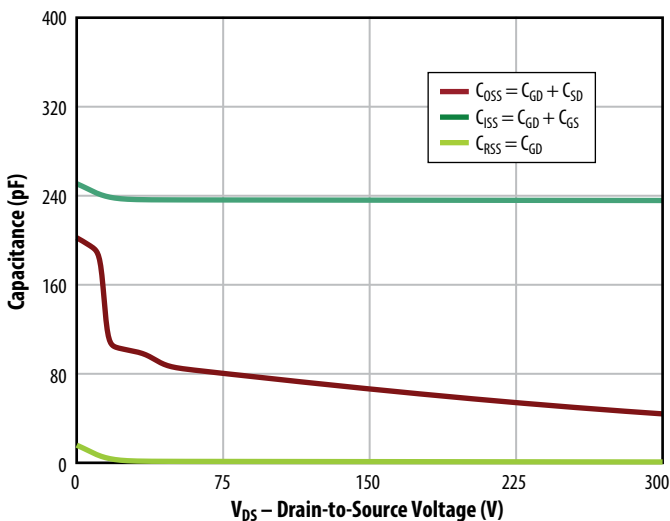


Figure 11: Typical Capacitance

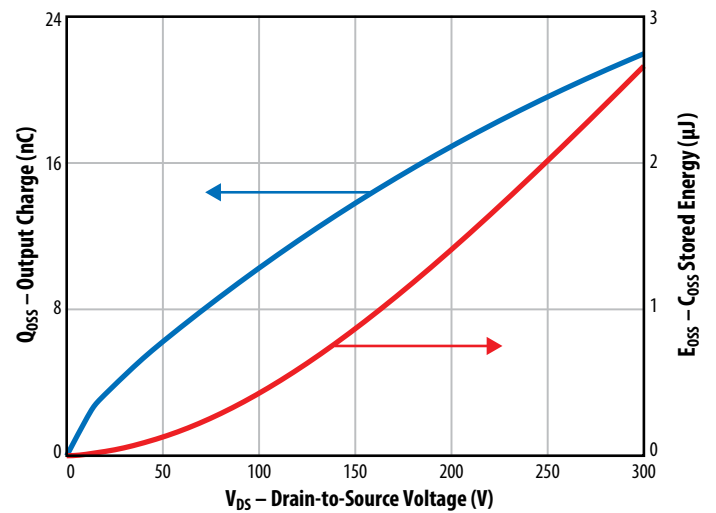


Figure 12: Typical Output Charge and  $C_{OSS}$  Stored Energy

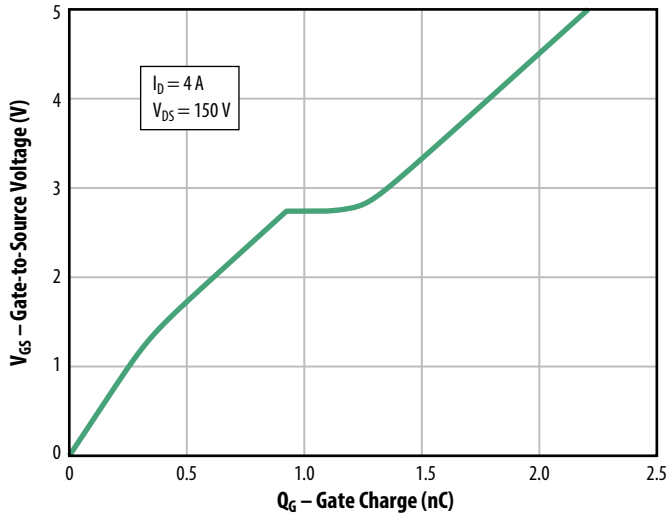


Figure 13: Typical Gate Charge

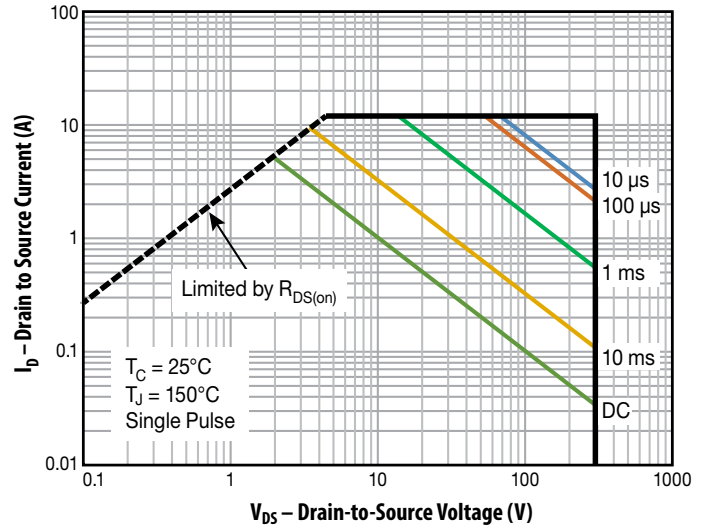
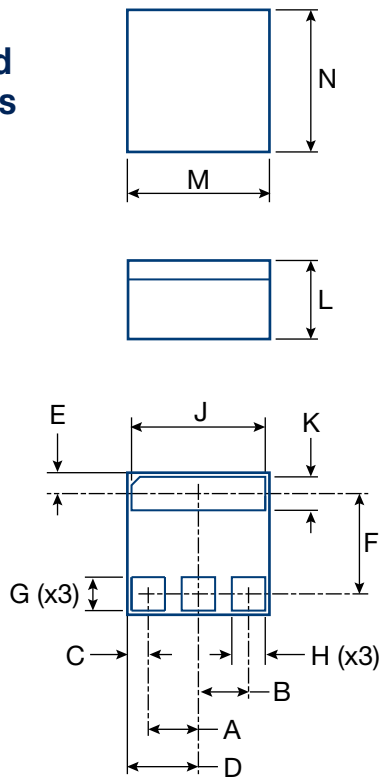


Figure 14: Safe Operating Area

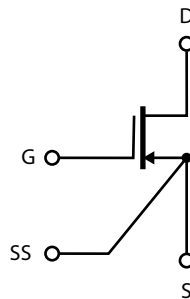
Package Outline and Dimensions



| Symbol | IN    |       | MM   |      |
|--------|-------|-------|------|------|
|        | NOM   | REF   | NOM  | REF  |
| A      | 0.06  |       | 1.52 |      |
| B      | 0.06  |       | 1.52 |      |
| C      |       | 0.022 |      | 0.56 |
| D      | 0.085 |       | 2.16 |      |
| E      |       | 0.025 |      | 0.64 |
| F      | 0.12  |       | 3.05 |      |
| G      | 0.04  |       | 1.02 |      |
| H      | 0.04  |       | 1.02 |      |
| J      | 0.16  |       | 4.06 |      |
| K      | 0.04  |       | 1.02 |      |
| L      |       | 0.083 |      | 2.11 |
| M      | 0.17  |       | 4.32 |      |
| N      | 0.17  |       | 4.32 |      |

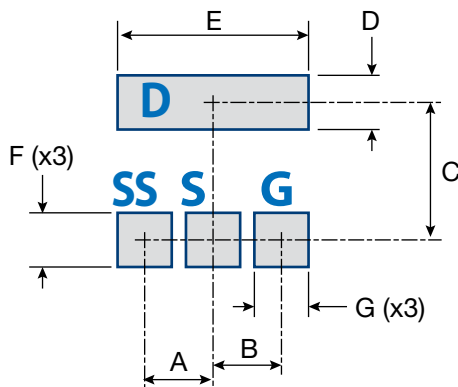
Note: All dimensions have a tolerance of  $\pm 0.005$  in [ $\pm 0.13$  mm]  
 Standard Terminal Pad finish is a solder alloy of 63%Sn 37%Pb

Package Connections



NOTE: SS pin is connected directly to source of internal die.

FSMD-C Footprint for Printed Circuit Board Design



| Symbol | IN    | MM   | Note |
|--------|-------|------|------|
|        | NOM   | NOM  |      |
| A      | 0.053 | 1.35 |      |
| B      | 0.053 | 1.35 |      |
| C      | 0.106 | 2.69 |      |
| D      | 0.041 | 1.04 |      |
| E      | 0.147 | 3.73 |      |
| F      | 0.041 | 1.04 |      |
| G      | 0.041 | 1.04 |      |

Suggested footprint:  
 NOM. DIM = .003 in [0.08 mm] swell on average

## Notes

- Note 1. Never exceed the absolute maximum  $V_{DS}$  of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum  $V_{GS}$  of the device otherwise permanent damage/destruction may result. We recommend a  $V_{GS}$  of 5V for optimum operation across life and radiation.
- Note 3.  $R_{\theta JA}$  measured with FSMD-C package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80  $\mu$ s and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current ( $I_{const}$ ) is provided to the Gate of the DUT during the time that the ground switch ( $G_S$ ) is OFF ( $t_{off}$ ). The DUT is switched ON and OFF using ground-sensed switch  $G_S$ . The gate current is adjusted to yield the desired charge per unit time ( $I_{const} \cdot \text{time per division}$ ) on the measuring oscilloscope. The  $G_S$  pulse drive ON time ( $t_{on}$ ) is adjusted for the desired observability of the gate-source voltage ( $V_{GS}$ ) waveform. The maximum duty cycle of the ground switch ( $t_{off}/t_{on}$ ) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5  $V_{DC}$ .

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